

## INSTRUCTION DIVISION FIRST SEMESTER 2015-2016 Course Handout Part II

Date:03/08/2015

In addition to part -I (General Handout for all courses appended to the Time Table), this portion gives further specific details regarding the course.

Course No. : EEE C381/ EEE/INSTR F214

Course Title : Electronic Devices & Integrated Circuits/

**Electronic Devices** 

Instructor-in-Charge : V K CHAUBEY (vkc@pilani.bits-pilani.ac.in)
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,Vinita Tiwari, Arnab Hazra.

### 1. Scope and Objective:

The course provides a comprehensive understanding of the basic theory of semiconductors and devices made out of it. Starting by explaining the fundamentals of semiconductors like energy band formation, electron and hole concepts, effect of electric and magnetic fields on charge carriers, the course helps in developing the understanding about excess carriers in semiconductors and its device application. In-depth study on 'junctions' prepares the students for even a detailed study on devices to be studied later like FET and BJT viz. commonly employed in Integrated Circuit (IC) technology. Concepts of some advanced semiconductor devices suitable for high frequency and infrared-optical range will also be discussed.

#### 2. Text Book:

B. G. Streetman, and Sanjay Banerjee, "Solid State Electronic Devices", 6<sup>th</sup> ed., PHI learning Private Limited, New Delhi, 2009

#### 3. Reference Books:

- 1. D A. Neaman, "Semiconductor Physics and Devices", 3<sup>rd</sup> edition, Tata Mc Graw Hill, New Delhi
- 2. M S Tyagi, "Introduction to Semiconductor Materials and Devices" John, NewYork 1991.

### 4. Course Plan:

Lecture No.	Topic	Learning Objectives	Reference to text
1-3	Introduction to subject and review of semiconductor fundamentals.	Basics of Semiconductor materials, Direct and Indirect semiconductors, Band gap, effective mass.	Class notes
4-5	Charge carriers in semiconductors,	Fermi level, equilibrium carrier concentrations, temperature dependence, space charge neutrality	3.3
6-7	Effect of electric and magnetic fields on drift of carriers	Conductivity and mobility, Hall effect	3.4-3.5
8-10	Excess carriers in semiconductors	Photon induced carrier generation, generation recombination of excess carriers, quasi-fermi levels in non equilibrium	4.1 – 4.4







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11-16	PN Junction Equilibrium conditions, Fermi levels, IV		5.2 - 5.6	
		characteristics, biasing, transient and AC		
		conditions, secondary effects		
17-18	Metal Semiconductor Junction	Schottky Barrier, Rectifying contacts and ohmic	5.7	
		contacts.		
19-22	Field Effect Transistors	To understand the structure and working of	6.2 - 6.4	
		JFET, Metal-Semiconductor FET and MISFET,		
		MOS capacitors (ideal and real)		
23-25	Field Effect Transistors	MOSFET, I-V characteristics and secondary	6.5 and	
		effects	Lecture	
			notes	
26-30	Bipolar Junction Transistors	BJT operations, amplifications, carrier	7.3 - 7.5	
		distribution, I-V characteristics etc. and	and	
		secondary effects	Lecture	
			notes	
31-34	Optoelectronic devices	Photodiodes, Solar cells, LEDs, Lasers and	8.1 - 8.4	
		Semiconductor Lasers		
35-38	High frequency and high power	Basic Structure and conduction mechanism of	10.1 - 10.6	
	devices	Tunnel diodes, IMPATT diodes, Gunn diodes		
39-40	Recent trends in semiconductor	Device Integration and Introduction to Integrated	Lecture	
	devices	Circuits and recent advancement	Notes	

## 5. Evaluation Scheme:

Component	Duration	Marks (300)	Date & Time	Evaluation type
Mid Sem. Exam	90 mins	100	9/10 2:00 - 3:30 PM	Closed Book
Assignment		30		Quiz based on Assignments
				(Closed Book)
Surprise Quizzes	10 mins	50	Tutorial	Closed Book
Compre. Exam.	3 hours	120	11/12 FN	Closed Book+ Open Book

- **6. Tutorials:** Tutorial sheets will be distributed in all tutorial hours.
- 7. Chamber Consultation hours: To be announced in the class.
- **8. Notices**: All notices concerning the course will be displayed on EEE notice board.
- **9. Make-up Examination:** Make-up will be given **ONLY** in cases of <u>sickness (hospitalization)</u> or <u>urgency</u> for going out of station. (no make-up will be given for assignments and surprise quizzes)

Instructor-in-Charge EEE C381



